## Search Notes



| Application/Control N | 0 |
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10517930

KUTAY ET AL.

Applicant(s)/Patent Under Reexamination

Examiner

**Art Unit** 

Cernoch, Steven M

4114

## **SEARCHED**

| Class          | Subclass | Date      | Examiner |
|----------------|----------|-----------|----------|
| 239            | 373      | 10/9/2007 | SMC      |
| 239            | 302      | 10/1/2007 | SMC      |
| 239            | 330      | 10/1/2007 | SMC      |
| 239            | 334      | 10/1/2007 | SMC      |
| 239            | 349      | 10/1/2007 | SMC      |
| 239            | 351      | 10/1/2007 | SMC      |
| 239            | 360      | 10/1/2007 | SMC      |
| 239            | 452      | 10/1/2007 | SMC      |
| 239            | 525      | 10/1/2007 | SMC      |
| 239            | 527      | 10/1/2007 | SMC      |
| 239            | 533.1    | 10/1/2007 | SMC      |
| 239            | 533.4    | 10/1/2007 | SMC      |
| 239            | 569      | 10/1/2007 | SMC      |
| 239            | 572      | 10/1/2007 | SMC      |
| 417            | 413.1    | 10/4/2007 | SMC      |
| 417            | 413.3    | 10/4/2007 | SMC      |
| 417            | 76       | 10/3/2007 | SMC      |
| 417            | 86       | 10/3/2007 | SMC      |
| 417            | 540      | 10/9/2007 | SMC      |
| Updated search |          | 1/31/08   | SMC      |

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| Search Notes | Date      | Examiner |
|--------------|-----------|----------|
| EAST         | 9/25/2007 | SMC      |
| EAST         | 9/26/2007 | SMC      |
| EAST         | 9/27/2007 | SMC      |
| EAST         | 10/1/2007 | SMC      |
| EAST         | 10/3/2007 | SMC      |
| EAST         | 10/4/2007 | SMC      |
| EAST         | 10/9/2007 | SMC      |

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